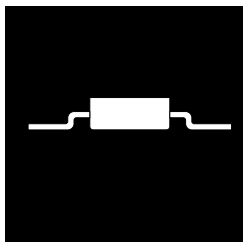


POWER MOSFET IN HERMETIC ISOLATED SURFACE MOUNT PACKAGE



**100V Thru 500V, Up To 10 Amp,
N-Channel Power MOSFETs In A
Hermetic Surface Mount Package**

FEATURES

- Isolated Hermetic Metal Package
- Fast Switching, Low Drive Current
- Ease of Paralleling For Added Power
- Low $R_{DS(on)}$
- Available Screened To MIL-S-19500, TX, TXV and S Levels

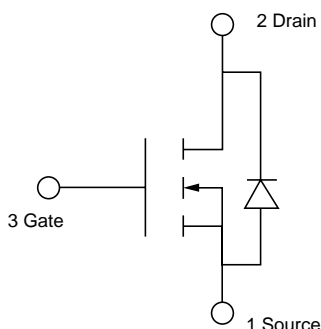
DESCRIPTION

This series of hermetically packaged surface mount products feature the latest advanced MOSFET and packaging technology. They are ideally suited for Military requirements where small size, high performance and high reliability are required, and in surface mount applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

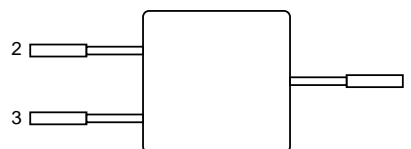
MAXIMUM RATINGS @ $T_C = 25^\circ C$

PART NUMBER	V_{DS}	$R_{DS(on)}$	I_D
OM6038SM	100V	.20	14A
OM6039SM	200V	.44	9A
OM6040SM	400V	1.05	5A
OM6041SM	500V	1.60	4A

SCHEMATIC



PIN CONNECTION



Pin 1: Source
Pin 2: Drain
Pin 3: Gate
Case: Isolated

3.5

**ELECTRICAL CHARACTERISTICS: (T_C = 25°C unless otherwise noted)
STATIC P/N OM6101ST / OM6038SM (100V)**

Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV _{DSS} Drain-Source Breakdown Voltage	100			V	V _{GS} = 0, I _b = 250 μA
V _{GS(th)} Gate-Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _b = 250 μA
I _{GSS} Gate-Body Leakage		± 500		nA	V _{GS} = ± 12.8 V
I _{BSS} Gate-Body Leakage		± 100		nA	V _{GS} = ± 20 V
I _{DSS} Zero Gate Voltage Drain Current		0.1	0.25	mA	V _{DS} = Max. Rat., V _{GS} = 0
		0.2	1.0	mA	V _{DS} = 0.8 Max. Rat., V _{GS} = 0, T _C = 125°C
I _{D(on)} On-State Drain Current ¹	14			A	V _{DS} = 2 V _{DSS(on)} , V _{GS} = 10 V
V _{DS(on)} Static Drain-Source On-State Voltage ¹		1.2	1.60	V	V _{GS} = 10 V, I _b = 8 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹		0.20			V _{GS} = 10 V, I _b = 8 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹		0.40			V _{GS} = 10 V, I _b = 8 A, T _C = 125°C

DYNAMIC

	4.0		S(f)	V _{DS}	2 V _{DSS(on)}	I _b	8 A
g _{fs} Forward Transconductance ¹		750		pF	V _{GS} = 0		
C _{iss} Input Capacitance		250		pF	V _{DS} = 25 V		
C _{oss} Output Capacitance		100		pF	f = 1 MHz		
C _{res} Reverse Transfer Capacitance		15		ns	V _{DS} = 30 V, I _b = 8 A		
t _{turn(on)} Turn-On Delay Time		35		ns	R _θ = 7.5 Ω, V _{DS} = 10 V		
t _r Rise Time		38		ns			
t _{turn(off)} Turn-Off Delay Time		23		ns			
t _f Fall Time							

BODY-DRAIN DIODE RATINGS AND CHARACTERISTICS

	-14		Modified MOSPOWER symbol showing the integral P-N Junction rectifier.
I _S Continuous Source Current (Body Diode)			
I _{SM} Source Current ¹ (Body Diode)			
V _{SD} Diode Forward Voltage ¹		-2.5	V
t _r Reverse Recovery Time	100		ns

1 Pulse Test: Pulse Width 300 μsec, Duty Cycle 2%.

**ELECTRICAL CHARACTERISTICS: (T_C = 25°C unless otherwise noted)
STATIC P/N OM6039SM (200V)**

Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV _{DSS} Drain-Source Breakdown Voltage	200			V	V _{GS} = 0, I _b = 250 μA
V _{GS(th)} Gate-Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _b = 250 μA
I _{GSS} Gate-Body Leakage		± 500		nA	V _{GS} = ± 12.8 V
I _{BSS} Gate-Body Leakage		± 100		nA	V _{GS} = ± 20 V
I _{DSS} Zero Gate Voltage Drain Current		0.1	0.25	mA	V _{DS} = Max. Rat., V _{GS} = 0
		0.2	1.0	mA	V _{DS} = 0.8 Max. Rat., V _{GS} = 0, T _C = 125°C
I _{D(on)} On-State Drain Current ¹	9.0			A	V _{DS} = 2 V _{DSS(on)} , V _{GS} = 10 V
V _{DS(on)} Static Drain-Source On-State Voltage ¹		1.25	2.2	V	V _{GS} = 10 V, I _b = 5.0 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹		0.44			V _{GS} = 10 V, I _b = 5.0 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹		0.88			V _{GS} = 10 V, I _b = 5.0 A, T _C = 125°C

DYNAMIC

	3.0	5.8		S(f)	2 V _{DSS(on)}	I _b	5.0 A
g _{fs} Forward Transconductance ¹		780		pF	V _{GS} = 0		
C _{iss} Input Capacitance		150		pF	V _{DS} = 25 V		
C _{oss} Output Capacitance		55		pF	f = 1 MHz		
C _{res} Reverse Transfer Capacitance		9		ns	V _{DS} = 75 V, I _b = 5.0 A		
t _{turn(on)} Turn-On Delay Time		18		ns	R _θ = 7.5 Ω, V _{DS} = 10 V		
t _r Rise Time		45		ns			
t _{turn(off)} Turn-Off Delay Time		27		ns			
t _f Fall Time							

BODY-DRAIN DIODE RATINGS AND CHARACTERISTICS

		-9	Modified MOSPOWER symbol showing the integral P-N Junction rectifier.
I _S Continuous Source Current (Body Diode)			
I _{SM} Source Current ¹ (Body Diode)			
V _{SD} Diode Forward Voltage ¹		-2	V
t _r Reverse Recovery Time	250		ns

1 Pulse Test: Pulse Width 300 μsec, Duty Cycle 2%.

**ELECTRICAL CHARACTERISTICS: (T_C = 25°C unless otherwise noted)
STATIC P/N OM6103ST / OM6040SM (400V)**

Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV _{DSS} Drain-Source Breakdown Voltage	400			V	V _{GS} = 0, I _b = 250 μA
V _{GS(th)} Gate-Threshold Voltage	2.0	4.0	4.0	V	V _{DS} = V _{GS} , I _b = 250 μA
I _{GSS} Gate-Body Leakage (OM6103)		± 500	± 500	nA	V _{GS} = ± 12.8 V
I _{GSS} Gate-Body Leakage (OM6003)		± 100	± 100	nA	V _{GS} = ± 20 V
I _{BSS} Zero Gate Voltage Drain Current		0.1	0.25	mA	V _{DS} = Max. Rat., V _{GS} = 0, T _C = 125° C
		0.2	1.0	mA	
I _{D(on)} On-State Drain Current ¹	5.5			A	V _{DS} = 2 V _{DS(on)} , V _{GS} = 10 V
V _{DS(on)} Static Drain-Source On-State Voltage ¹	2.4	3.15	3.15	V	V _{GS} = 10 V, I _b = 3.0 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹	1.05				V _{GS} = 10 V, I _b = 3.0 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹			2.0		V _{GS} = 10 V, I _b = 3.0 A, T _C = 125° C

DYNAMIC

g _{fs} Forward Transconductance ¹	3.0	3.6	S(Ω)	V _{DS} = 2 V _{DS(on)} , I _b = 3.0 A
C _{iss} Input Capacitance	700		pF	V _{GS} = 0
C _{oss} Output Capacitance	70		pF	V _{DS} = 25 V
C _{rss} Reverse Transfer Capacitance	20		pF	f = 1 MHz
t _{fd(on)} Turn-On Delay Time	18		ns	V _{DD} = 175 V, I _b = 3.0 A
t _r Rise Time	20		ns	R _θ = 10 Ω, V _{GS} = 10 V
t _{fd(off)} Turn-Off Delay Time	40		ns	
t _f Fall Time	25		ns	

BODY-DRAIN DIODE RATINGS AND CHARACTERISTICS

I _S Continuous Source Current (Body Diode)	- 5.5	A	Modified MOSPOWER symbol showing the integral P-N Junction rectifier.
I _{SM} Source Current ¹ (Body Diode)	- 22	A	
V _{SD} Diode Forward Voltage ¹	- 1.6	V	T _C = 25°C, I _S = -5.5 A, V _{GS} = 0 T _C = 25°C, I _S = -4.5 A, V _{GS} = 0
t _{rr} Reverse Recovery Time	470	ns	T _J = 150°C, I _r = I _S , dI _r /ds = 100 A/μs

1 Pulse Test: Pulse Width 300 μsec, Duty Cycle 2%.

**ELECTRICAL CHARACTERISTICS: (T_C = 25°C unless otherwise noted)
STATIC P/N OM6104ST / OM6041SM (500V)**

Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV _{DSS} Drain-Source Breakdown Voltage	500			V	V _{GS} = 0, I _b = 250 μA
V _{GS(th)} Gate-Threshold Voltage	2.0	4.0	4.0	V	V _{DS} = V _{GS} , I _b = 250 μA
I _{GSS} Gate-Body Leakage (OM6104)		± 500	± 500	nA	V _{GS} = ± 12.8 V
I _{GSS} Gate-Body Leakage (OM6004)		± 100	± 100	nA	V _{GS} = ± 20 V
I _{BSS} Zero Gate Voltage Drain Current		0.1	0.25	mA	V _{DS} = Max. Rat., V _{GS} = 0, T _C = 125° C
		0.2	1.0	mA	
I _{D(on)} On-State Drain Current ¹	4.5			A	V _{DS} = 2 V _{DS(on)} , V _{GS} = 10 V
V _{DS(on)} Static Drain-Source On-State Voltage ¹	3.25	4.00	4.00	V	V _{GS} = 10 V, I _b = 2.5 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹	1.6				V _{GS} = 10 V, I _b = 2.5 A
R _{DS(on)} Static Drain-Source On-State Resistance ¹	2.9	3.3	3.3		V _{GS} = 10 V, I _b = 2.5 A, T _C = 125° C

DYNAMIC

g _{fs} Forward Transconductance ¹	2.5	2.8	S(Ω)	V _{DS} = 2 V _{DS(on)} , I _b = 2.5 A
C _{iss} Input Capacitance	700		pF	V _{GS} = 0
C _{oss} Output Capacitance	90		pF	V _{DS} = 25 V
C _{rss} Reverse Transfer Capacitance	30		pF	f = 1 MHz
t _{fd(on)} Turn-On Delay Time	18		ns	V _{DD} = 225 V, I _b = 2.5 A
t _r Rise Time	20		ns	R _θ = 7.5 Ω, V _{GS} = 10 V
t _{fd(off)} Turn-Off Delay Time	42		ns	
t _f Fall Time	25		ns	

BODY-DRAIN DIODE RATINGS AND CHARACTERISTICS

I _S Continuous Source Current (Body Diode)	- 4.5	A	Modified MOSPOWER symbol showing the integral P-N Junction rectifier.
I _{SM} Source Current ¹ (Body Diode)	- 18	A	
V _{SD} Diode Forward Voltage ¹	- 1.4	V	T _C = 25°C, I _S = -4.5 A, V _{GS} = 0 T _C = 25°C, I _S = -4 A, V _{GS} = 0
t _{rr} Reverse Recovery Time	430	ns	T _J = 150°C, I _r = I _S , dI _r /ds = 100 A/μs

1 Pulse Test: Pulse Width 300 μsec, Duty Cycle 2%.



ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Parameter	OM6038	OM6039	OM6040	OM6041	Units	
V_{DS}	100	200	400	500	V	
V_{DGR}	100	200	400	500	V	
$I_D @ T_C = 25^\circ\text{C}$	± 14	± 9	± 5	± 4	A	
$I_D @ T_C = 100^\circ\text{C}$	± 7	± 5	± 3	± 2	A	
I_{DM}	± 45	± 35	± 18	± 10	A	
$P_D @ T_C = 25^\circ\text{C}$	50	50	50	50	W	
$P_D @ T_C = 100^\circ\text{C}$	25	25	25	25	W	
Junction To Case	Linear Derating Factor	0.4	0.4	0.4	0.4	W/ $^\circ\text{C}$
Junction To Ambient	Linear Derating Factor	.0125	.0125	.0125	.0125	W/ $^\circ\text{C}$
T_J	Operating and					
T_{stg}	Storage Temperature Range	-55 to 150	-55 to 150	-55 to 150	-55 to 150	$^\circ\text{C}$
Lead Solder Temperature (1/16" from case for 5 secs.)		225	225	225	225	$^\circ\text{C}$

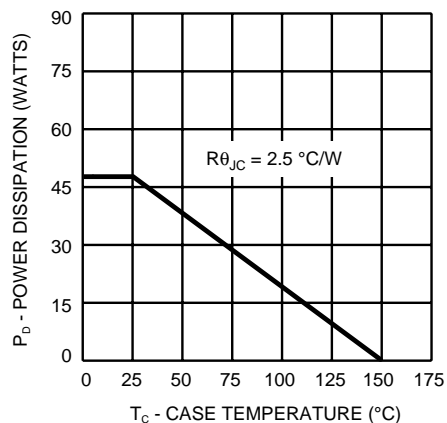
1 **Pulse Test:** Pulse width 300 μsec . Duty Cycle 2%.

2 **Package PIN Limitations** = 15 Amps

THERMAL RESISTANCE

R_{thJC}	Junction-to-Case	2.5	$^\circ\text{C}/\text{W}$	
R_{thJA}	Junction-to-Ambient	80	$^\circ\text{C}/\text{W}$	Free Air Operation

POWER DERATING



MECHANICAL OUTLINE

